

# IPD5N25S3430ATMA1 Datasheet



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DiGi Electronics Part Number	IPD5N25S3430ATMA1-DG
Manufacturer	<a href="#">Infineon Technologies</a>
Manufacturer Product Number	IPD5N25S3430ATMA1
Description	MOSFET N-CH 250V 5A TO252-3
Detailed Description	N-Channel 250 V 5A (Tc) 41W (Tc) Surface Mount PG -TO252-3-313



Tel: +00 852-30501935

RFQ Email: [Info@DiGi-Electronics.com](mailto:Info@DiGi-Electronics.com)

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## Purchase and inquiry

**Manufacturer Product Number:**

IPD5N25S3430ATMA1

**Series:**

OptiMOS™

**FET Type:**

N-Channel

**Drain to Source Voltage (Vdss):**

250 V

**Drive Voltage (Max Rds On, Min Rds On):**

10V

**Vgs(th) (Max) @ Id:**

4V @ 13µA

**Vgs (Max):**

±20V

**FET Feature:**

-

**Operating Temperature:**

-55°C ~ 175°C (Tj)

**Qualification:**

AEC-Q101

**Supplier Device Package:**

PG-TO252-3-313

**Base Product Number:**

IPD5N25

**Manufacturer:**

Infineon Technologies

**Product Status:**

Active

**Technology:**

MOSFET (Metal Oxide)

**Current - Continuous Drain (Id) @ 25°C:**

5A (Tc)

**Rds On (Max) @ Id, Vgs:**

430mOhm @ 5A, 10V

**Gate Charge (Qg) (Max) @ Vgs:**

6.2 nC @ 10 V

**Input Capacitance (Ciss) (Max) @ Vds:**

422 pF @ 25 V

**Power Dissipation (Max):**

41W (Tc)

**Grade:**

Automotive

**Mounting Type:**

Surface Mount

**Package / Case:**

TO-252-3, DPAK (2 Leads + Tab), SC-63

## Environmental & Export classification

**RoHS Status:**

ROHS3 Compliant

**REACH Status:**

REACH Unaffected

**HTSUS:**

8541.29.0095

**Moisture Sensitivity Level (MSL):**

1 (Unlimited)

**ECCN:**

EAR99



IPD5N25S3-430

## OptiMOS™ -T Power-Transistor



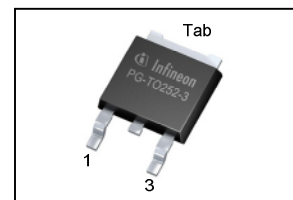
### Features

- N-channel - Enhancement mode
- AEC qualified
- MSL1 up to 260°C peak reflow
- 175°C operating temperature
- Green Product (RoHS compliant)
- 100% Avalanche tested

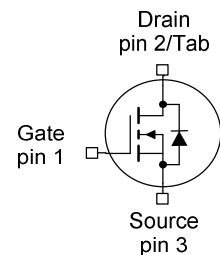
### Product Summary

$V_{DS}$	250	V
$R_{DS(on),max}$	430	m $\Omega$
$I_D$	5	A

PG-TO252-3-313



Type	Package	Marking
IPD5N25S3-430	PG-TO252-3-	3N25430



Maximum ratings, at  $T_j=25^\circ\text{C}$ , unless otherwise specified

Parameter	Symbol	Conditions	Value	Unit
Continuous drain current	$I_D$	$T_C=25^\circ\text{C}$ , $V_{GS}=10\text{V}$	5	A
		$T_C=100^\circ\text{C}$ , $V_{GS}=10\text{V}^{1)}$	4	
Pulsed drain current <sup>1)</sup>	$I_{D,pulse}$	$T_C=25^\circ\text{C}$	20	
Avalanche energy, single pulse <sup>1)</sup>	$E_{AS}$	$I_D=1.3\text{A}$	13	mJ
Avalanche current, single pulse	$I_{AS}$	-	1.3	A
Reverse diode $dv/dt$	$dv/dt$		6	kV/ $\mu\text{s}$
Gate source voltage	$V_{GS}$	-	$\pm 20$	V
Power dissipation	$P_{tot}$	$T_C=25^\circ\text{C}$	41	W
Operating and storage temperature	$T_j$ , $T_{stg}$	-	-55 ... +175	$^\circ\text{C}$
IEC climatic category; DIN IEC 68-1	-	-	55/175/56	



Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	
<b>Thermal characteristics<sup>1)</sup></b>						
Thermal resistance, junction - case	$R_{thJC}$	-	-	-	3.7	K/W
SMD version, device on PCB	$R_{thJA}$	minimal footprint	-	-	40	
		6 cm <sup>2</sup> cooling area <sup>2)</sup>	-	-	62	

**Electrical characteristics**, at  $T_j=25^\circ\text{C}$ , unless otherwise specified

#### Static characteristics

Drain-source breakdown voltage	$V_{(BR)DSS}$	$V_{GS}=0V, I_D=1\text{mA}$	250	-	-	V
Gate threshold voltage	$V_{GS(th)}$	$V_{DS}=V_{GS}, I_D=13\mu\text{A}$	2.0	3.0	4.0	
Zero gate voltage drain current	$I_{DSS}$	$V_{DS}=250V, V_{GS}=0V, T_j=25^\circ\text{C}$	-	0.1	1	$\mu\text{A}$
		$V_{DS}=250V, V_{GS}=0V, T_j=125^\circ\text{C}^{2)}$	-	10	100	
Gate-source leakage current	$I_{GSS}$	$V_{GS}=20V, V_{DS}=0V$	-	1	100	nA
Drain-source on-state resistance	$R_{DS(on)}$	$V_{GS}=10V, I_D=5A$	-	370	430	m $\Omega$



Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	

**Dynamic characteristics<sup>1)</sup>**

Input capacitance	$C_{iss}$	$V_{GS}=0V, V_{DS}=25V,$ $f=1MHz$	-	317	422	pF
Output capacitance	$C_{oss}$		-	117	156	
Reverse transfer capacitance	$C_{rss}$		-	6	13	
Turn-on delay time	$t_{d(on)}$	$V_{DD}=125V, V_{GS}=10V,$ $I_D=5A, R_G=3.5\Omega$	-	3	-	ns
Rise time	$t_r$		-	2	-	
Turn-off delay time	$t_{d(off)}$		-	8	-	
Fall time	$t_f$		-	5	-	

**Gate Charge Characteristics<sup>1), 3)</sup>**

Gate to source charge	$Q_{gs}$	$V_{DD}=200V, I_D=5A,$ $V_{GS}=0$ to 10V	-	1.5	2	nC
Gate to drain charge	$Q_{gd}$		-	1.3	2.7	
Gate charge total	$Q_g$		-	4.7	6.2	
Gate plateau voltage	$V_{plateau}$		-	4.7	-	V

**Reverse Diode**

Diode continuous forward current <sup>1)</sup>	$I_S$	$T_C=25^\circ C$	-	-	5	A
Diode pulse current <sup>1)</sup>	$I_{S,pulse}$		-	-	20	
Diode forward voltage	$V_{SD}$	$V_{GS}=0V, I_F=5A,$ $T_j=25^\circ C$	-	0.9	1.2	V
Reverse recovery time <sup>1)</sup>	$t_{rr}$	$V_R=125V, I_F=5A,$ $di_F/dt=100A/\mu s$	-	70	-	ns
Reverse recovery charge <sup>1)</sup>	$Q_{rr}$		-	159	-	nC

<sup>1)</sup> Defined by design. Not subject to production test.

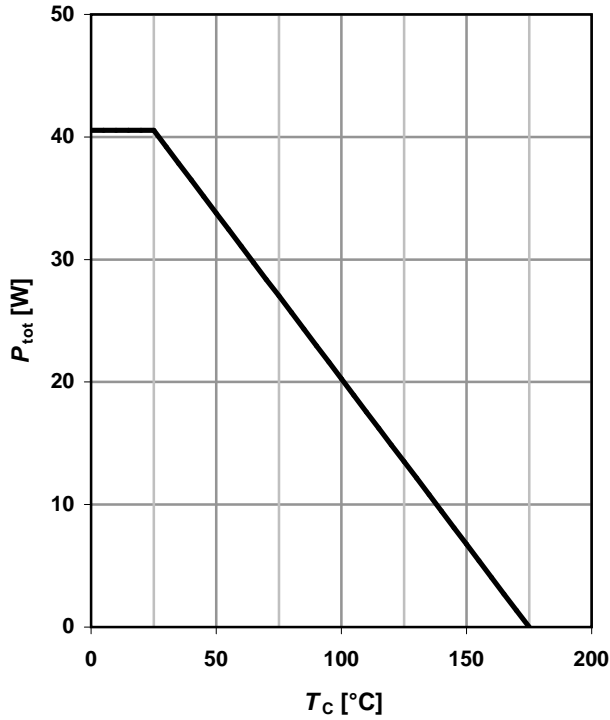
<sup>2)</sup> Device on 40 mm x 40 mm x 1.5 mm epoxy PCB FR4 with 6 cm<sup>2</sup> (one layer, 70 μm thick) copper area for drain connection. PCB is vertical in still air.

<sup>3)</sup> Devices thermal performance determined according to EIA JESD 51-14  
"Transient Dual Interface Test Method For The Measurement Of The Thermal Resistance"



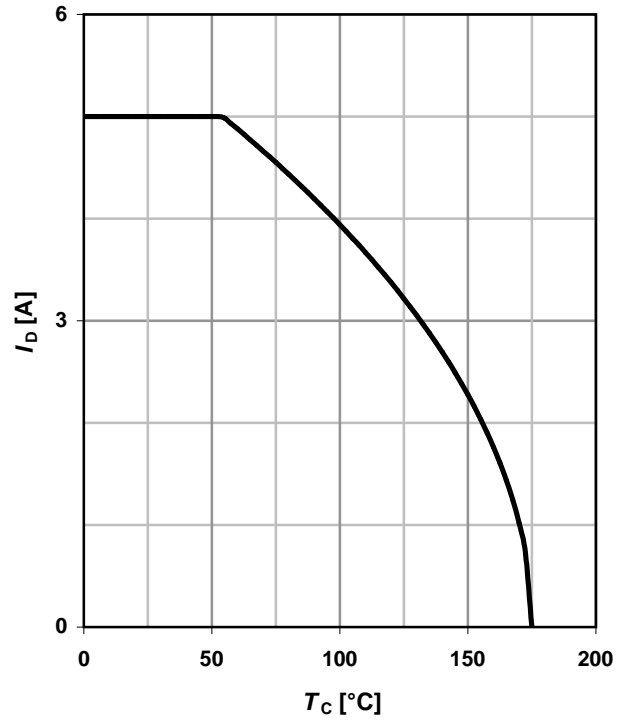
**1 Power dissipation**

$P_{tot} = f(T_C); V_{GS} \geq 6\text{ V}$



**2 Drain current**

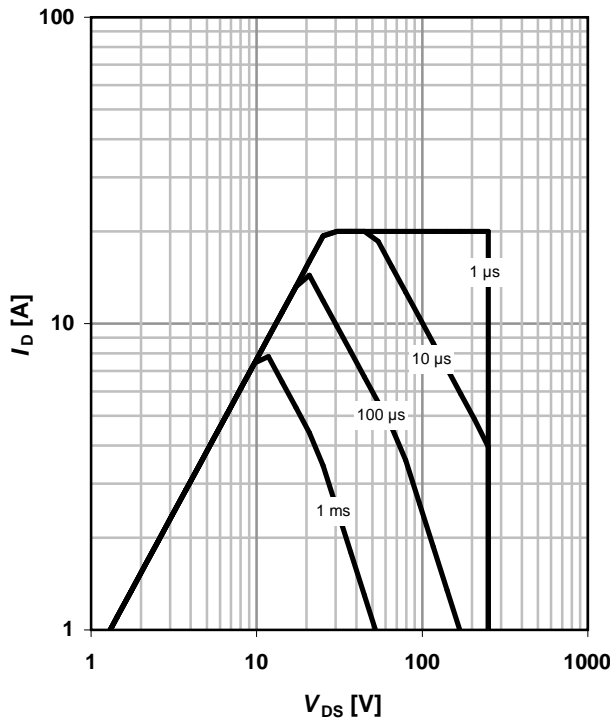
$I_D = f(T_C); V_{GS} \geq 6\text{ V}$



**3 Safe operating area**

$I_D = f(V_{DS}); T_C = 25\text{ °C}; D = 0$

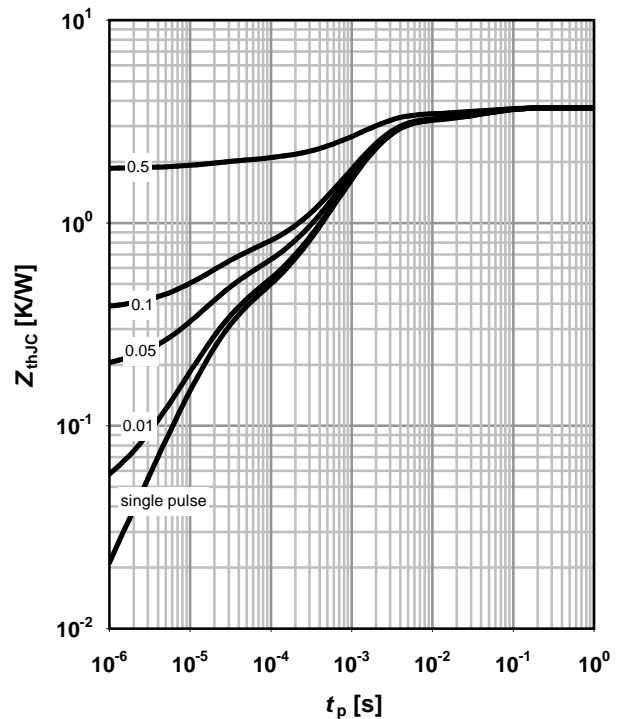
parameter:  $t_p$



**4 Max. transient thermal impedance**

$Z_{thJC} = f(t_p)$

parameter:  $D = t_p/T$

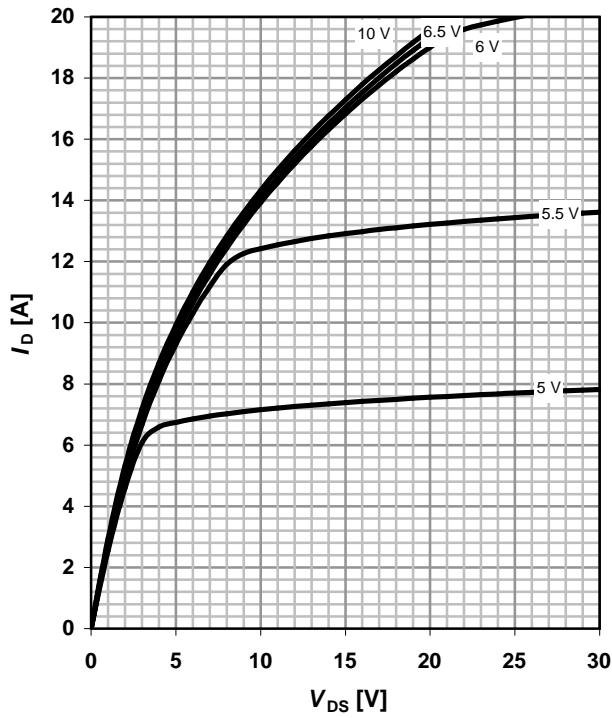




**5 Typ. output characteristics**

$I_D = f(V_{DS}); T_j = 25\text{ }^\circ\text{C}$

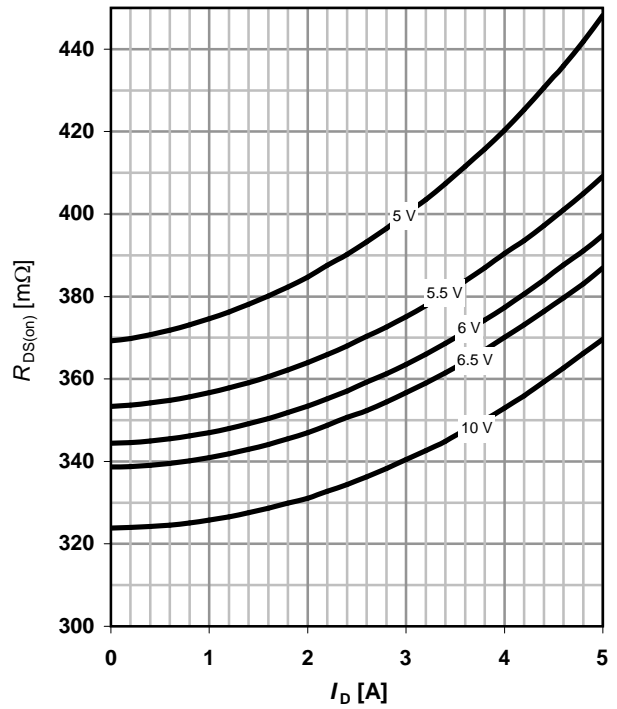
parameter:  $V_{GS}$



**6 Typ. drain-source on-state resistance**

$R_{DS(on)} = f(I_D); T_j = 25\text{ }^\circ\text{C}$

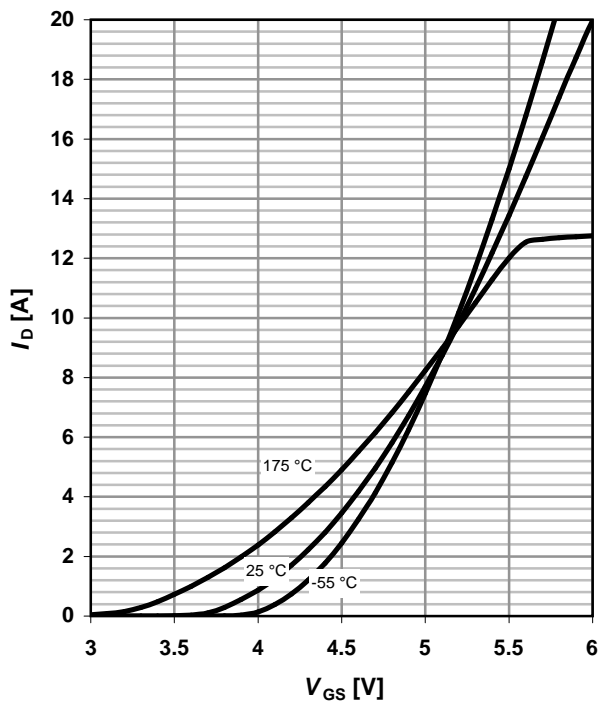
parameter:  $V_{GS}$



**7 Typ. transfer characteristics**

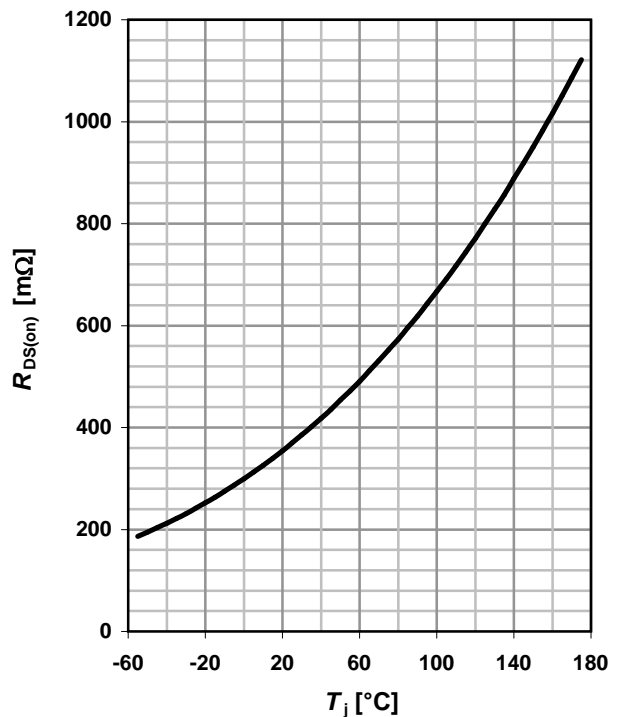
$I_D = f(V_{GS}); V_{DS} = 6\text{V}$

parameter:  $T_j$



**8 Typ. drain-source on-state resistance**

$R_{DS(on)} = f(T_j); I_D = 5\text{ A}; V_{GS} = 10\text{ V}$

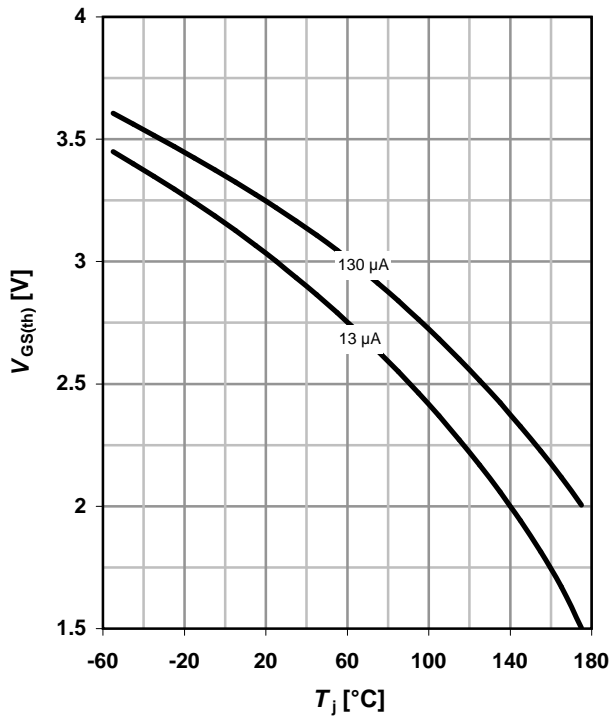




**9 Typ. gate threshold voltage**

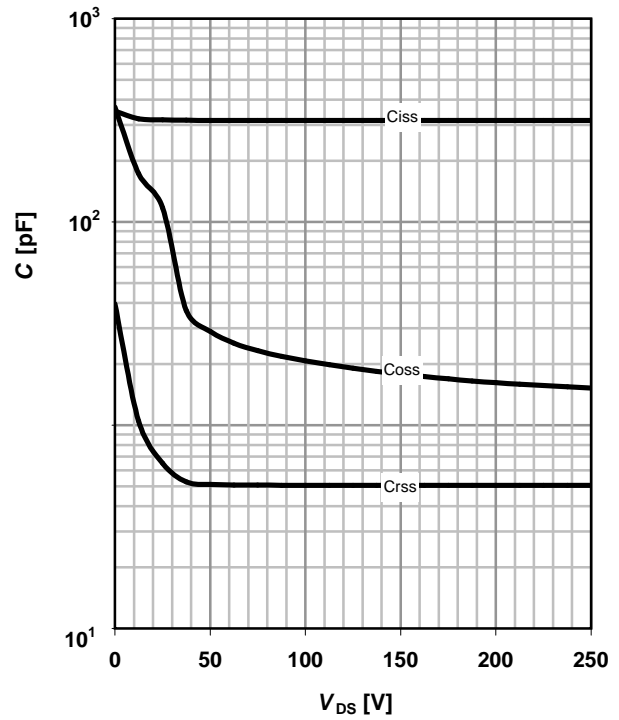
$V_{GS(th)} = f(T_j); V_{GS} = V_{DS}$

parameter:  $I_D$



**10 Typ. capacitances**

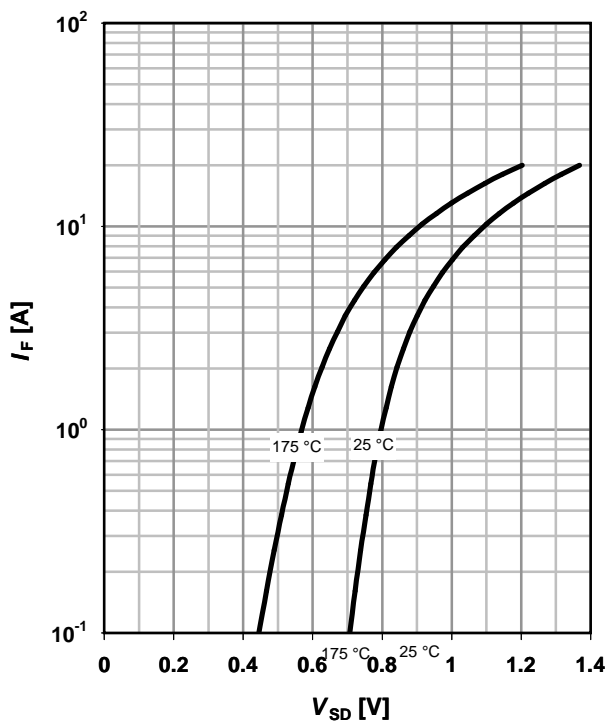
$C = f(V_{DS}); V_{GS} = 0 \text{ V}; f = 1 \text{ MHz}$



**11 Typical forward diode characteristics**

$I_F = f(V_{SD})$

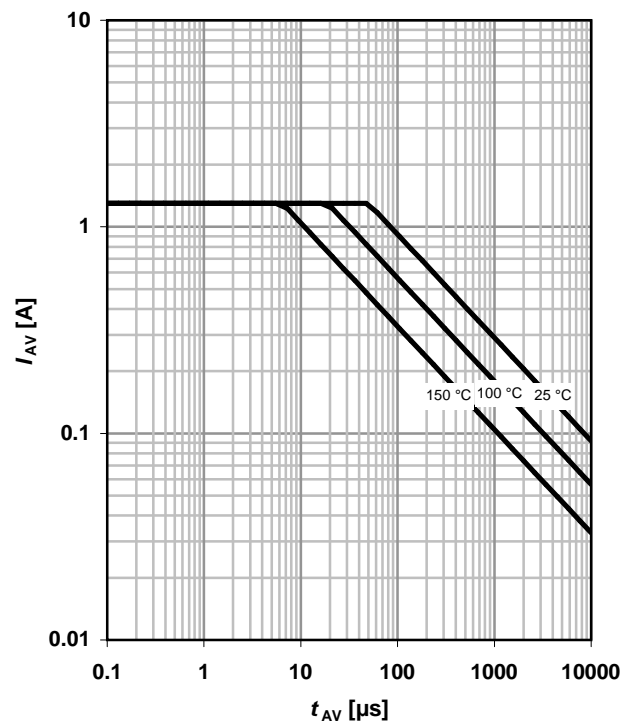
parameter:  $T_j$



**12 Avalanche characteristics**

$I_{AS} = f(t_{AV})$

parameter:  $T_{j(start)}$

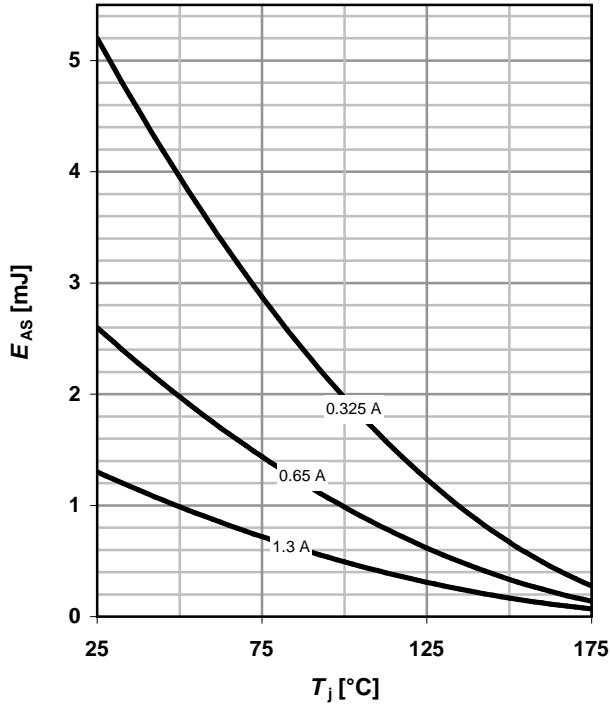






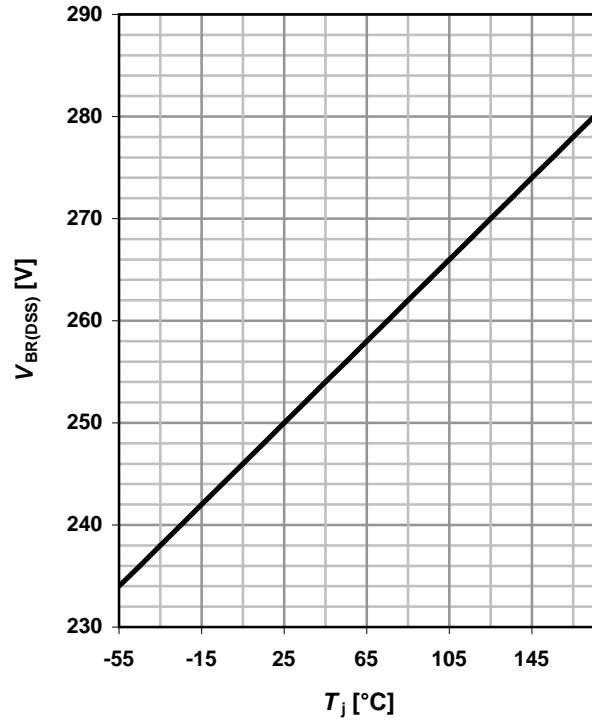
**13 Avalanche energy**

$E_{AS} = f(T_j); I_D = 45 \text{ A}$



**14 Drain-source breakdown voltage**

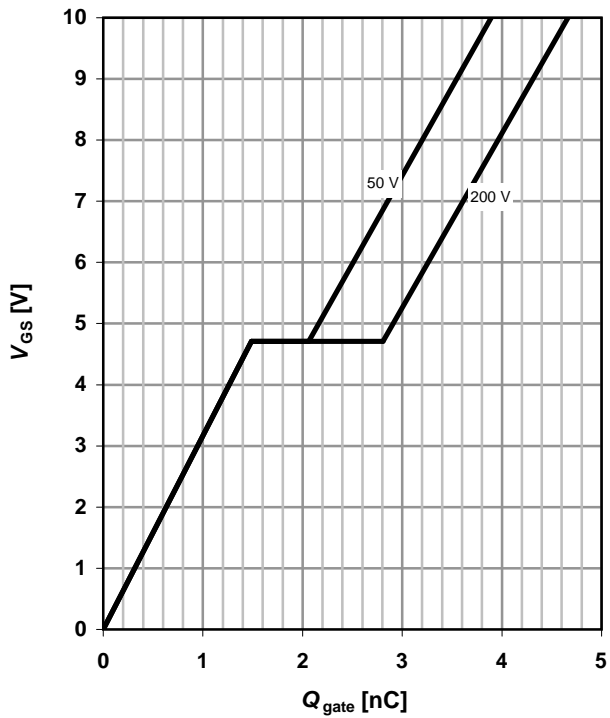
$V_{BR(DSS)} = f(T_j); I_D = 1 \text{ mA}$



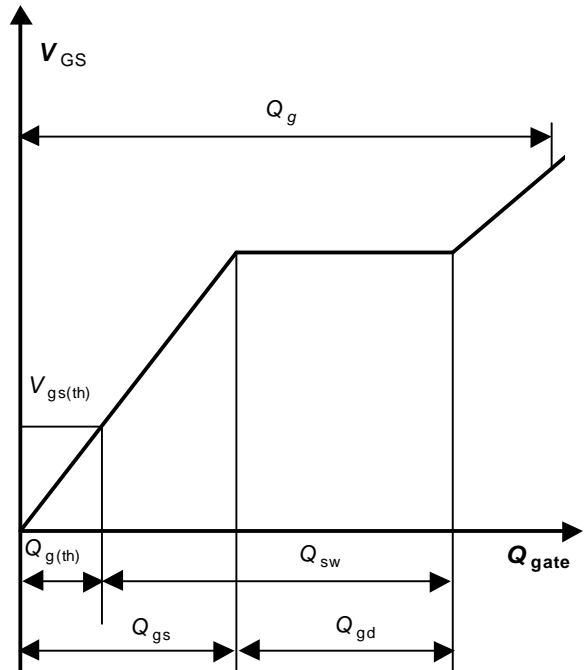
**15 Typ. gate charge**

$V_{GS} = f(Q_{gate}); I_D = 5 \text{ A pulsed}$

parameter:  $V_{DD}$



**16 Gate charge waveforms**





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## Revision History

Version	Date	Changes
Revision 0.1	21.10.2010	Initial target data sheet
Revision 0.2	24.07.2012	Preliminary data sheet
Revision 1.0	18.10.2012	Final Data Sheet

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